

# Silicon Carbide (SiC) Module – EliteSiC, 40 mohm SiC M1 MOSFET, 1200 V + 40 A, 1200 V SiC Diode, Three Channel Full SiC Boost, Q1 Package

# Product Preview

# NXH40B120MNQ1SNG

The NXH40B120MNQ1SNG is a power module containing a three channel boost stage. The integrated SiC MOSFETs and SiC Diodes provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

### **Features**

- 1200 V 40 mΩ SiC MOSFETs
- Low Reverse Recovery and Fast Switching SiC Diodes
- 1200 V Bypass and Anti-parallel Diodes
- Low Inductive Layout
- Solderable Pins
- Thermistor
- This Device is Pb–Free, Halogen Free/BFR Free and is RoHS Compliant

### **Typical Applications**

- Solar Inverters
- Uninterruptable Power Supplies

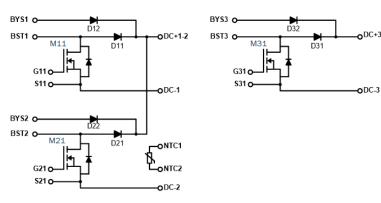
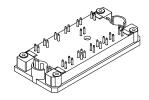


Figure 1. NXH80B120MNQ0SNG Schematic Diagram

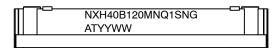
This document contains information on a product under development. **onsemi** reserves the right to change or discontinue this product without notice.

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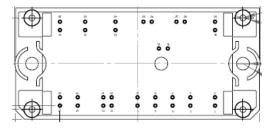
PIM32, 71x37.4 (SOLDER PIN) CASE 180BQ

### MARKING DIAGRAM



NXH40B120MNQ1SNG = Device Code
G = Pb-Free Package
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

### **PIN CONNECTIONS**



### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 4 of this data sheet.

### **ABSOLUTE MAXIMUM RATINGS** (Note 1) $T_J = 25^{\circ}C$ unless otherwise noted

Rating	Symbol	Value	Unit
BOOST SIC MOSFET (M11, M21, M31)			•
Drain-Source Voltage	$V_{DS}$	1200	V
Gate-Source Voltage	$V_{GS}$	-15/+25	V
Continuous Drain Current (@ V <sub>GS</sub> = 20 V, T <sub>C</sub> = 80°C)	I <sub>D</sub>	44	А
Pulsed Drain Current @ T <sub>C</sub> = 80°C (T <sub>J</sub> = 175°C)	I <sub>D(Pulse)</sub>	132	А
Maximum Power Dissipation @ T <sub>C</sub> = 80°C	P <sub>tot</sub>	156	W
Minimum Operating Junction Temperature	$T_{JMIN}$	-40	°C
Maximum Operating Junction Temperature	$T_JMAX$	175	°C
BOOST DIODE (D11, D21, D31)	•		•
Peak Repetitive Reverse Voltage	$V_{RRM}$	1200	V
Continuous Forward Current @ T <sub>C</sub> = 80°C	I <sub>F</sub>	53	Α
Surge Forward Current (60 Hz single half-sine wave)	I <sub>FRM</sub>	159	Α
Maximum Power Dissipation @ T <sub>C</sub> = 80°C (T <sub>J</sub> = 175°C)	P <sub>tot</sub>	153	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C
BYPASS DIODE (D12, D22, D32)			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	1200	V
Continuous Forward Current @ T <sub>C</sub> = 80°C (T <sub>J</sub> = 150°C)	I <sub>F</sub>	75	А
Repetitive Peak Forward Current (T <sub>J</sub> = 150°C, t <sub>p</sub> limited by T <sub>Jmax</sub> )	I <sub>FRM</sub>	225	А
Power Dissipation Per Diode @ T <sub>C</sub> = 80°C (T <sub>J</sub> = 150°C)	P <sub>tot</sub>	97	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	150	°C
THERMAL PROPERTIES			
Storage Temperature range	T <sub>stg</sub>	-40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60 Hz	V <sub>is</sub>	3000	$V_{RMS}$
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### **RECOMMENDED OPERATING RANGES**

Parameter	Symbol	Min	Max	Unit
Module Operating Junction Temperature	TJ	-40	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

<sup>1.</sup> Refer to <u>ELECTRICAL CHĂRACTERISTICS</u>, <u>RECOMMENDED OPERATING RANGES</u> and/or APPLICATION INFORMATION for Safe Operating parameters.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST MOSFET CHARACTERIST	TCS (M11, M21, M31)					
Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 25°C	I <sub>DSS</sub>	_	_	200	μΑ
Static Drain-to-Source On	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 40 A, T <sub>J</sub> = 25°C	R <sub>DS(on)</sub>	_	40	55	mΩ
Resistance	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 40 A, T <sub>J</sub> = 175°C	1	=	60	-	
Gate-Source Leakage Current	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V	I <sub>GSS</sub>	_	-	1.0	μΑ
Turn-on Delay Time	T <sub>J</sub> = 25°C	t <sub>d(on)</sub>	_	17	_	ns
Rise Time	$V_{DS} = 700 \text{ V}, V_{GS} = -5 \text{ V} \text{ to } 20 \text{ V}$ $I_{D} = 40 \text{ A}, R_{G} = 4.7 \Omega$	t <sub>r</sub>		7.5	-	
Turn-off Delay Time	- 10 7 1, 1 1 <u>G</u> - 1.7 22	t <sub>d(off)</sub>	_	43.8	_	]
Fall Time	1	t <sub>f</sub>	=	17	=	
Turn-on Switching Loss per Pulse		E <sub>on</sub>	-	255	-	μJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	-	125.5	=	
Turn-on Delay Time	T <sub>J</sub> = 125°C	t <sub>d(on)</sub>	=	15.8	=	ns
Rise Time	$V_{DS} = 700 \text{ V}, V_{GS} = -5 \text{ V to } 20 \text{ V}$ $I_{D} = 40 \text{ A}, R_{G} = 4.7 \Omega$	t <sub>r</sub>	-	7	-	
Turn-off Delay Time	, d	t <sub>d(off)</sub>	=	46.5	=	
Fall Time		t <sub>f</sub>	Ī	15.3	-	
Turn-on Switching Loss per Pulse		E <sub>on</sub>	-	216	=	μJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	_	108.5	-	
Input Capacitance	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V, f = 1 MHz	C <sub>ies</sub>	-	3227	-	pF
Output Capacitance		C <sub>oes</sub>	_	829	-	
Reverse Transfer Capacitance		C <sub>res</sub>	_	19	_	
Total Gate Charge	V <sub>DS</sub> = 600 V, I <sub>D</sub> = 20 A, V <sub>GS</sub> = 20 V	Qg	_	112	_	nC
Thermal Resistance – chip-to- heatsink	Thermal grease, Thickness = 2 Mil ±2%	R <sub>thJH</sub>	-	0.88	-	K/W
Thermal Resistance - chip-to-case	$\lambda = 2.87 \text{ W/mK}$	R <sub>thJC</sub>	-	0.61	-	K/W
BOOST DIODE CHARACTERISTIC	S (D11, D21, D31)					-
Diode Reverse Leakage Current	V <sub>R</sub> = 1200 V	I <sub>R</sub>	-	_	400	μΑ
Diode Forward Voltage	I <sub>F</sub> = 40 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	1.2	1.57	1.9	V
	I <sub>F</sub> = 40 A, T <sub>J</sub> = 175°C		_	_	_	
Reverse Recovery Time	T <sub>J</sub> = 25°C	t <sub>rr</sub>	-	16.7	-	ns
Reverse Recovery Charge	$V_{DS}$ = 700 V, $V_{GS}$ = -5 V to 20 V $I_{D}$ = 40 A, $R_{G}$ = 4.7 $\Omega$	Q <sub>rr</sub>	_	329.6	_	nC
Peak Reverse Recovery Current	- 1D - 40 A, 11G - 4.7 S2	I <sub>RRM</sub>	_	34.3	_	Α
Peak Rate of Fall of Recovery Current	1	di/dt	_	6684	-	A/μs
Reverse Recovery Energy		E <sub>rr</sub>	_	176.6	_	Lμ
Reverse Recovery Time	T <sub>J</sub> = 125°C	t <sub>rr</sub>	=	16.9	=	ns
Reverse Recovery Charge	$V_{DS} = 700 \text{ V}, V_{GS} = -5 \text{ V to } 20 \text{ V}$	Q <sub>rr</sub>	-	361	_	nC
Peak Reverse Recovery Current	$I_D = 40 \text{ A}, R_G = 4.7 \Omega$	I <sub>RRM</sub>	-	37	-	Α
Peak Rate of Fall of Recovery Current		di/dt	-	8067	-	A/μs
Reverse Recovery Energy	1	E <sub>rr</sub>	_	209.1	=	μJ

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST DIODE CHARACTERISTIC	CS (D11, D21, D31)		•			
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil ±2%	$R_{ heta JH}$	_	0.87	_	K/W
Thermal Resistance - chip-to-case	$\lambda = 2.87 \text{ W/mK}$	$R_{ heta JC}$	_	0.62	_	K/W
BYPASS DIODE CHARACTERISTI	CS (D12, D22, D32)					
Diode Reverse Leakage Current	V <sub>R</sub> = 1200 V, T <sub>J</sub> = 25°C	I <sub>R</sub>	_	_	250	μА
Diode Forward Voltage	I <sub>F</sub> = 50 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	0.8	1.13	1.3	V
	I <sub>F</sub> = 50 A, T <sub>J</sub> = 150°C		=	-	-	
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil ±2%	$R_{ hetaJH}$	_	1.05	-	°C/W
Thermal Resistance - chip-to-case	$\lambda = 2.87 \text{ W/mK}$	$R_{ heta JC}$	_	0.72	_	°C/W
THERMISTOR CHARACTERISTIC	S		•			
Nominal resistance		R <sub>25</sub>	_	22	-	kΩ
Nominal resistance	T = 100°C	R <sub>100</sub>	_	1468	_	Ω
Deviation of R25		ΔR/R	-5	_	5	%
Power dissipation		P <sub>D</sub>	_	200	_	mW
Power dissipation constant			_	2	-	mW/K
B-value	B(25/50), tolerance ±3%		=	3950	=	К
B-value	B(25/100), tolerance ±3%		_	3998	-	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### **ORDERING INFORMATION**

Part Number	Marking	Package	Shipping
NXH40B120MNQ1SNG	NXH40B120MNQ1SNG	Q1 3-Channel BOOST - Case 180BQ Solder Pins (Pb - Free)	21 Units / Blister Tray

### TYPICAL CHARACTERISTICS - MOSFET, BOOST DIODE AND BYPASS DIODE

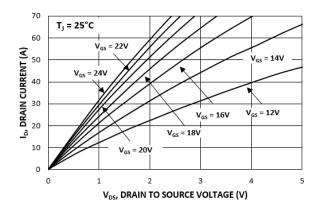


Figure 2. Typical Output Characteristics

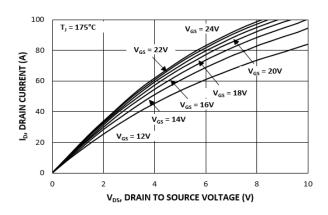


Figure 3. Typical Output Characteristics

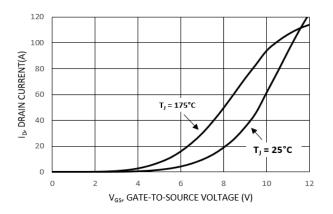


Figure 4. Typical Transfer Characteristics

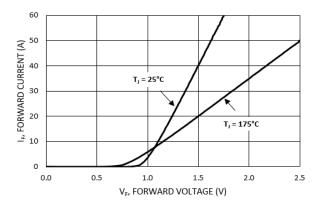


Figure 5. Boost Diode Forward Characteristics

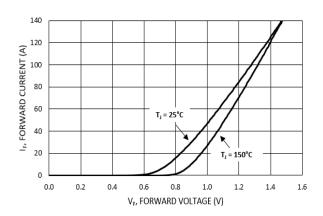


Figure 6. BYPASS Diode Forward Characteristics

### TYPICAL CHARACTERISTICS -MOSFET, BOOST DIODE AND BYPASS DIODE

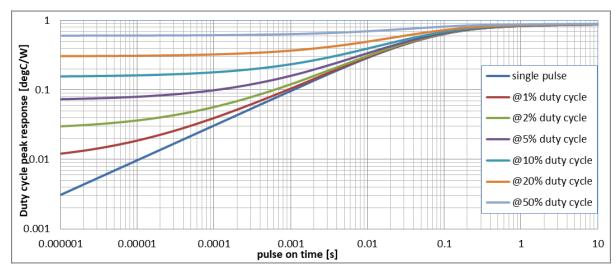


Figure 7. Transient Thermal Impedance (MOSFET)

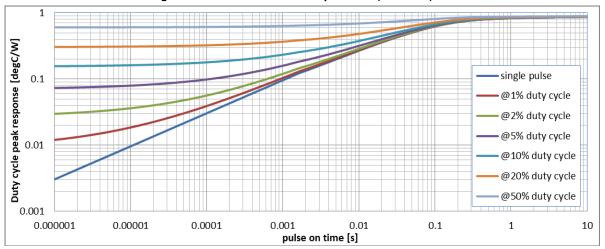


Figure 8. Transient Thermal Impedance (BOOST DIODE)

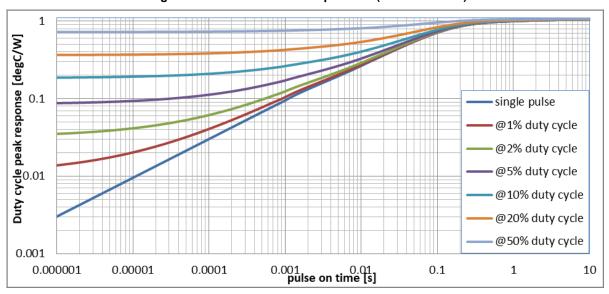


Figure 9. Transient Thermal Impedance (BYPASS DIODE)

### TYPICAL CHARACTERISTICS - MOSFET, BOOST DIODE AND BYPASS DIODE

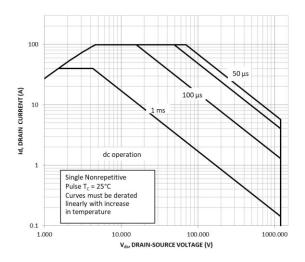


Figure 10. FBSOA



Charge (nC)

Figure 12. Gate Voltage vs. Gate Charge

120

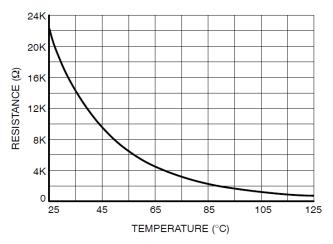


Figure 14. Thermistor Characteristics

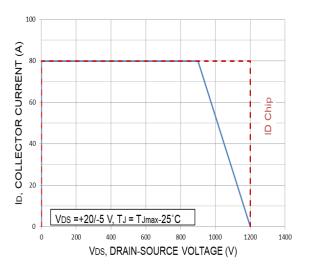


Figure 11. RBSOA

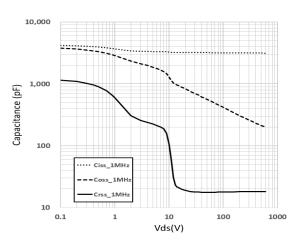


Figure 13. Capacitance Charge

### TYPICAL CHARACTERISTICS - MOSFET (M11, M21, M31) AND BOOST DIODE (D11, D21, D31)

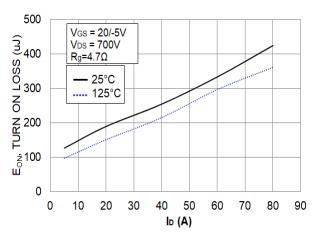


Figure 15. Typical Turn ON Loss vs. ID

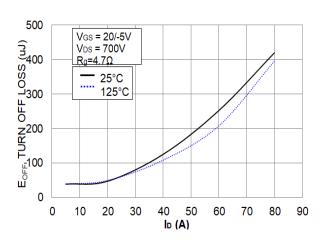


Figure 16. Typical Turn OFF Loss vs. ID

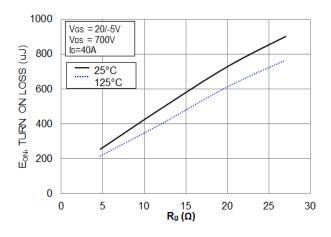


Figure 17. Typical Turn ON Loss vs. R<sub>G</sub>

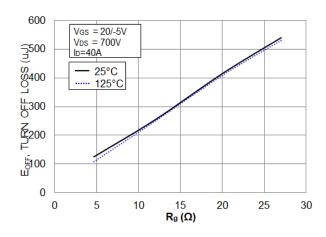


Figure 18. Typical Turn OFF Loss vs. R<sub>G</sub>

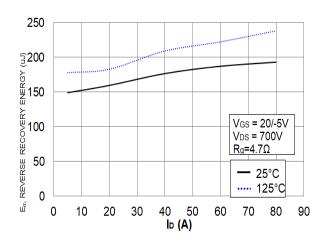


Figure 19. Typical Reverse Recovery Energy Loss vs. In

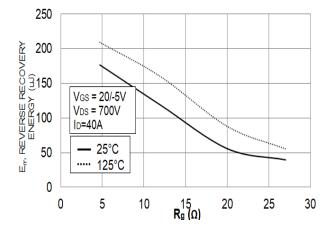


Figure 20. Typical Reverse Recovery Energy Loss vs.  $R_{\mbox{\scriptsize G}}$ 

### TYPICAL CHARACTERISTICS - MOSFET (M11, M21, M31) AND BOOST DIODE (D11, D21, D31) (continued)

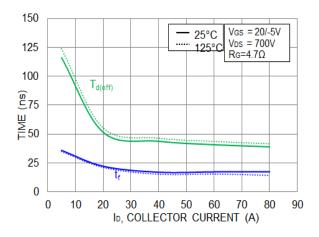


Figure 21. Typical Turn-Off Switching Time vs. ID

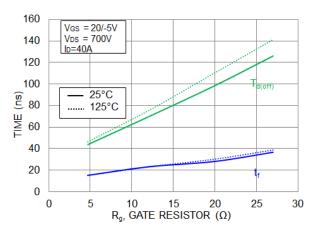


Figure 23. Typical Turn-Off Switching Time vs. R<sub>G</sub>

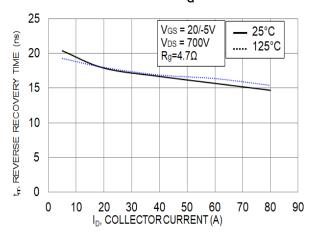


Figure 25. Inverse Diode Typical Reverse Recovery Time vs. I<sub>D</sub>

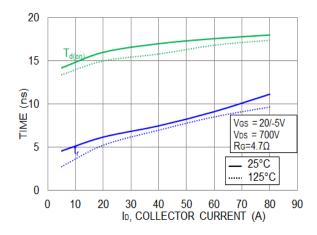


Figure 22. Typical Turn-On Switching Time vs. I<sub>D</sub>

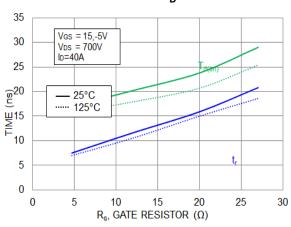


Figure 24. Typical Turn-On Switching Time vs. R<sub>G</sub>

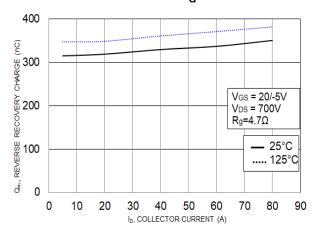
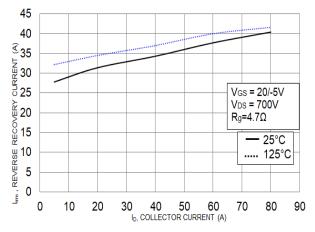


Figure 26. Typical Reverse Recovery Charge vs.  $I_{\rm D}$ 

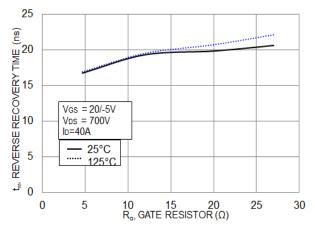
### TYPICAL CHARACTERISTICS - MOSFET (M11, M21, M31) AND BOOST DIODE (D11, D21, D31) (continued)



12000 DIODE CURRENT SLOPE (A'us) 10000 8000 Vgs = 20/-5V 6000 V<sub>DS</sub> = 700V  $R_g=4.7\Omega$ 4000 - 25°C ..... 125°C 2000 di/dt, l 0 0 70 80 90 10

Figure 27. Inverse Diode Typical Reverse Recovery Current vs.  $I_D$ 

Figure 28. Typical di/dt Current Slope versus I<sub>D</sub>



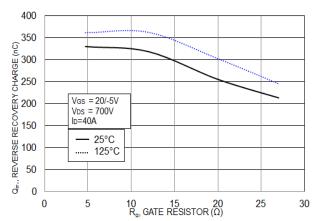
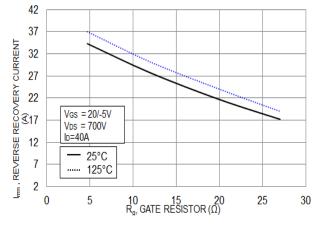


Figure 29. Typical Reverse Recovery Time vs. R<sub>G</sub>

Figure 30. Inverse Diode
Typical Reverse Recovery Charge vs. R<sub>G</sub>



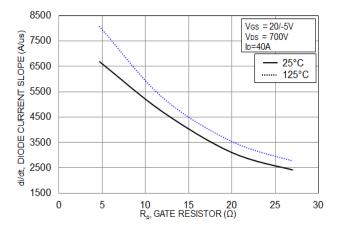


Figure 31. Typical Reverse Recovery Peak Current versus R<sub>G</sub>

Figure 32. Inverse Diode Typical di/dt vs. R<sub>G</sub>



### **PIM32, 71x37.4 (SOLDER PIN)** CASE 180BQ **ISSUE A**

**DATE 23 JUL 2021** 

PIN POSITION

-14.10

-11.30

11.30

14.10

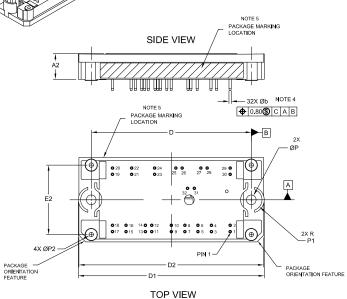
11.30

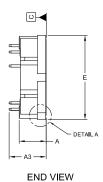
14.10

11.30

14.10

14.10





	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
Α	11.70	12.00	12.30	
A2	10.90	11.40	11.90	
А3	15.90	16.40	16.90	
A5	0.00	-	0.45	
b	0.90	1.00	1.10	
D	70.50	71.00	71.50	
D1	82.00	82.50	83.00	
D2	81.50	82.00	82.50	
E	36.90	37.40	37.90	
E2	30.30	30.80	31.30	
Р	4.30	4.40	4.50	
P1	4.55	4.75	4.95	
P2	2.00 REF			

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**DETAIL A** 

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NOTE 4

Х 26.10 -14.10 17 -26.10 26.10 -11.30 18 -26.10 17.80 -14.10 19 -26.10 17.80 -11.30 20 -26.10 21 11.80 -14.10 -17.60 11.80 -11.30 22 -17.60 6.00 -14.10 23 -7.40 6.00 -11.30 24 -7.40 0.00 -14.10 25 2.00

PIN POSITION

0.00 -11.30 26 4.80 14.10 27 -8.70 -14.10 13.10 14.10 -11.30 28 14.10 12 8.70 15.90 13 -11.50 -14.10 29 26.10 14.10 14 -11.50 -11.30 30 26.10 11.30 15 -20.10 -14.10 31 10.20 5.10 -20.10 7.20 5.10

### RECOMMENDED MOUNTING PATTERN\*

ORIGIN FOR MOUNTING HOLE LOCATIONS

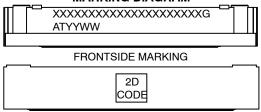
0.00

THRU HOLE Ø9 20

For additional information on our Pb-Free strategy and soldering details, please download the On Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION; MILLIMETERS
- 3. DIMENSION b APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
- 4. POSITION OF THE CENTER OF THE TERMINALS AND MOUNTING HOLES IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO BOTH TERMINALS AND MOUNTING HOLES IN BOTH DIRECTIONS.
- 5. PACKAGE MARKING IS LOCATED, AS SHOWN, ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.
- 6. MOUNTING RECOMMENDATION IS SHOWN AS VIEWED FROM THE PCB TOP LAYER LOOKING DOWN TO SUBSEQUENT LAYERS.

### **GENERIC MARKING DIAGRAM\***



### **BACKSIDE MARKING**

XXXXX = Specific Device Code

G = Pb-Free Package

ΑT = Assembly & Test Site Code YYWW = Year and Work Week Code \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "", may or may not be present. Some products may not follow the Generic Marking.

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